



IPC-6013B

Qualification and Performance Specification for Flexible Printed Boards

Developed by the Flexible Circuits Performance Specifications
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Users of this publication are encouraged to participate in the
development of future revisions.

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Qualification and Performance Specification for Flexible Printed Boards

1 SCOPE

1.1 Statement of Scope This specification covers qualification and performance requirements of flexible printed boards (PBs). The flexible PB may be single-sided, double-sided, multilayer, or rigid-flex multilayer. All of these constructions may or may not include stiffeners, plated-through holes (PTHs), and blind/buried vias.

The flexible or rigid-flex PB may contain build up high density interconnect (HDI) layers conforming to IPC-6016. The PB may contain active embedded passive circuitry with distributive capacitive planes, capacitive or resistive components.

The rigid section of the PB may contain a metal core or external metal heat frame, which may be active or nonactive.

Revision level changes are described in 1.7.

1.2 Purpose The purpose of this specification is to provide requirements for qualification and performance of flexible PBs designed to IPC-2221 and IPC-2223.

1.3 Performance Classification, PB Type, and Installation Usage

1.3.1 Classification This specification recognizes that flexible PBs will be subject to variations in performance requirements based on end-use. These performance classes (Class 1, Class 2, and Class 3) are defined in IPC-6011.

1.3.2 PB Type Performance requirements are established for the different types of flexible PBs, classified as follows:

- Type 1 Single-sided flexible PBs containing one conductive layer, with or without stiffeners.
- Type 2 Double-sided flexible PBs containing two conductive layers with PTHs, with or without stiffeners.
- Type 3 Multilayer flexible PBs containing three or more conductive layers with PTHs, with or without stiffeners.
- Type 4 Multilayer rigid and flexible material combinations containing three or more conductive layers with PTHs.
- Type 5 Flexible or rigid-flex PBs containing two or more conductive layers without PTHs.

1.3.3 Installation Uses

Use A Capable of withstanding flex during installation.

Use B Capable of withstanding continuous flexing for the number of cycles as specified in the procurement documentation.

Use C High temperature environment (over 105 °C [221 °F]).

Use D UL Recognition.

1.3.4 Selection for Procurement For procurement purposes, performance class and installation usage **shall** be specified in the procurement documentation.

The documentation **shall** provide sufficient information to the supplier so that the supplier can fabricate the flexible PBs and ensure that the user receives the desired product. Information that should be included in the procurement documentation is shown in IPC-D-325.

Note: If the drawing specifies the requirement in words, designators are not required.

1.3.4.1 Selection (Default) The procurement documentation should specify the requirements that can be selected within this specification. However, in the event that these selections are not made in the documentation, Table 1-1 **shall** apply:

1.3.5 Material, Plating Process and Final Finish

1.3.5.1 Laminate Material Laminate material is identified by numbers and/or letters, classes and types as specified by the appropriate specification listed in the procurement documentation.

1.3.5.2 Plating Process The copper plating process used to provide the main conductor in the holes is identified by a single number as follows:

1. Acid copper electroplating only
2. Pyrophosphate copper electroplating only
3. Acid and/or pyrophosphate copper electroplating
4. Additive/electroless copper
5. Electrodeposited Nickel underplate with copper electroplating

Note: Pyrophosphate copper electroplating is no longer in use.

1.3.5.3 Final Finish The final finish can be but is not limited to one of the designators given below or a combination of several platings and is dependent on assembly